

NI 6230 Specifications

Specifications listed below are typical at 25 °C unless otherwise noted.

Analog Input

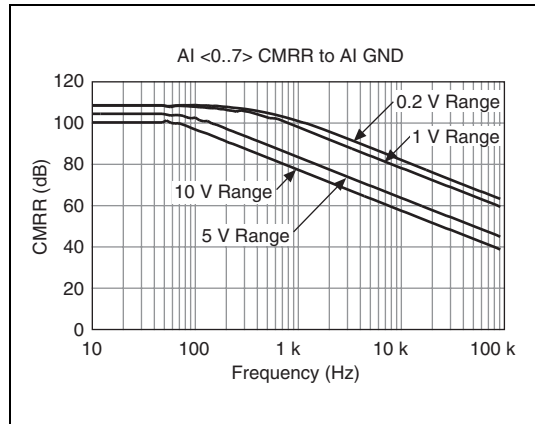
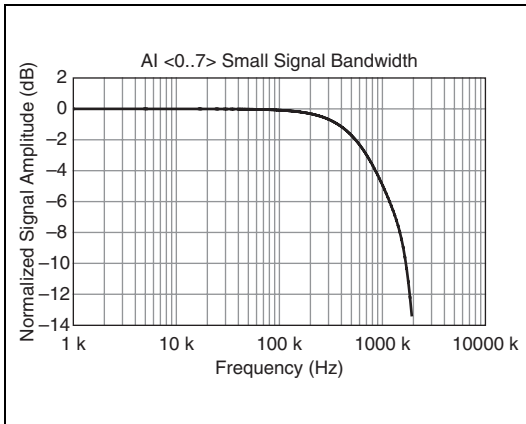
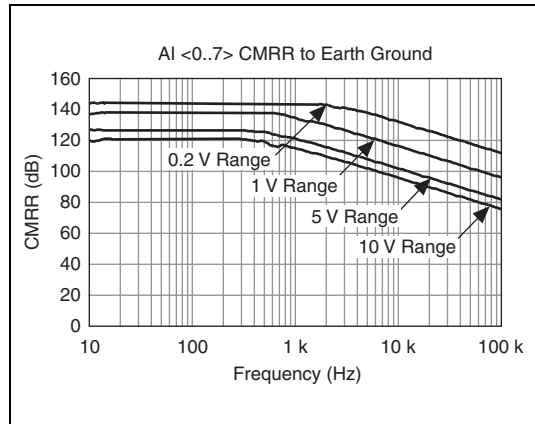
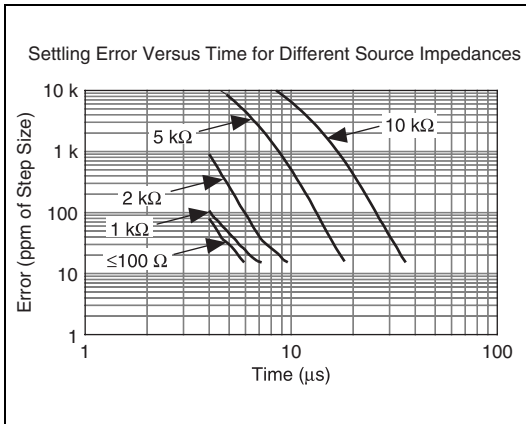
Number of channels	4 differential or 8 single ended
Channel type	Voltage input
ADC resolution	16 bits
DNL	No missing codes guaranteed
INL	Refer to the <i>AI Absolute Accuracy Table</i>
Sampling rate	
Maximum	250 KS/s
Minimum	0 S/s
Timing accuracy	50 ppm of sample rate
Timing resolution	50 ns
Input coupling	DC
Input range	± 10 V, ± 5 V, ± 1 V, ± 0.2 V
Maximum working voltage for analog inputs	Refer to the <i>Maximum Working Voltage</i> section
CMRR (DC to 60 Hz)	95 dB (with respect to AI GND)
Input impedance	
Device on	
AI+ to AI GND	>10 G Ω in parallel with 100 pF
AI- to AI GND	>10 G Ω in parallel with 100 pF
Device off	
AI+ to AI GND	820 Ω
AI- to AI GND	820 Ω
Input bias current	± 100 pA

Crosstalk (at 100 kHz)	
Adjacent channels	-75 dB
Non-adjacent channels	-90 dB
Small signal bandwidth (-3 dB)	700 kHz
Input FIFO size	4,095 samples
Scan list memory	4,095 entries
Data transfers	DMA (scatter-gather), interrupts, programmed I/O
Overvoltage protection (AI $<0..7$) with respect to AI GND)	
Device on	± 25 V for up to two AI pins
Device off	± 15 V for up to two AI pins
Input current during overvoltage condition	± 20 mA max/AI pin

Settling Time for Multichannel Measurements

Accuracy, full scale step, all ranges	
± 90 ppm of step (± 6 LSB)	4 μ s convert interval
± 30 ppm of step (± 2 LSB)	5 μ s convert interval
± 15 ppm of step (± 1 LSB)	7 μ s convert interval

Typical Performance Graphs



Analog Output

Number of channels	4
Channel type	Voltage output
DAC resolution	16 bits
DNL	±1 LSB
Monotonicity	16 bit guaranteed
Maximum update rate	
1 channel.....	500 kS/s
2 channels	450 kS/s per channel
3 channels	425 kS/s per channel
4 channels	400 kS/s per channel
Timing accuracy	50 ppm of sample rate
Timing resolution.....	50 ns
Output range	±10 V
Output coupling	DC
Output impedance	0.4 Ω
Output current drive.....	±5 mA
Overdrive protection	±25 V
Overdrive current.....	10 mA
Power-on state.....	±20 mV
Power-on glitch ¹	±2 V for 2 ms
Power-off glitch ²	±100 mV for 350 ms
Output FIFO size	8,191 samples shared among channels used
Data transfers	DMA (scatter-gather), interrupts, programmed I/O

AO waveform modes:

- Non-periodic waveform
- Periodic waveform regeneration mode from onboard FIFO
- Periodic waveform regeneration from host buffer including dynamic update

Settling time, full scale step

15 ppm (1 LSB) 6 μs

Slew rate 15 V/μs

Glitch energy

 Magnitude..... 100 mV

 Duration..... 3 μs

Calibration (AI and AO)

Recommended warm-up time 15 minutes

Calibration interval..... 1 year

¹ For the earlier version of the PCI-6230 (192233B-01), refer to the *NI 6230 Specifications* document, 371672A-01, January 2006 revision.

² When outputting 0 V on power down from the analog output channel.

AI Absolute Accuracy Table

Nominal Range	Positive Full Scale	Negative Full Scale	Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INL Error (ppm of Range)	Random Noise, σ (μ Vrms)	Absolute Accuracy at Full Scale ¹ (μ V)	Sensitivity ² (μ V)
	10	-10	75	25	5	20	57	76	244	3,100	97.6
	5	-5	85	25	5	20	60	76	122	1,620	48.8
	1	-1	95	25	5	25	79	76	30	360	12.0
	0.2	-0.2	135	25	5	80	175	76	13	112	5.2

AbsoluteAccuracy = Reading · (GainError) + Range · (OffsetError) + NoiseUncertainty

GainError = ResidualGainError + GainTempco · (TempChangeFromLastInternalCal) + ReferenceTempco · (TempChangeFromLastExternalCal)

OffsetError = ResidualOffsetError + OffsetTempco · (TempChangeFromLastInternalCal) + INL_Error

NoiseUncertainty = $\frac{\text{RandomNoise} \cdot 3}{\sqrt{100}}$ For a coverage factor of 3 σ and averaging 100 points.

¹ Absolute accuracy at full scale on the analog input channels is determined using the following assumptions:

TempChangeFromLastExternalCal = 10 °C

TempChangeFromLastInternalCal = 1 °C

number_of_readings = 100

CoverageFactor = 3 σ

For example, on the 10 V range, the absolute accuracy at full scale is as follows:

GainError = 75 ppm + 25 ppm · 1 + 5 ppm · 10

GainError = 150 ppm

OffsetError = 20 ppm + 57 ppm · 1 + 76 ppm

OffsetError = 153 ppm

NoiseUncertainty = $\frac{244 \mu\text{V} \cdot 3}{\sqrt{100}}$ NoiseUncertainty = 73 μ V

AbsoluteAccuracy = 10 V · (GainError) + 10 V · (OffsetError) + NoiseUncertainty AbsoluteAccuracy = 3,100 μ V

² Sensitivity is the smallest voltage change that can be detected. It is a function of noise.

Accuracies listed are valid for up to one year from the device external calibration.

AO Absolute Accuracy Table

Nominal Range		Residual Gain Error (ppm of Reading)	Gain Tempco (ppm/°C)	Reference Tempco	Residual Offset Error (ppm of Range)	Offset Tempco (ppm of Range/°C)	INL Error (ppm of Range)	Absolute Accuracy at Full Scale ¹ (µV)
Positive Full Scale	Negative Full Scale							
10	-10	90	10	5	40	5	128	3,230

¹ Absolute Accuracy at full scale numbers is valid immediately following internal calibration and assumes the device is operating within 10 °C of the last external calibration. Accuracies listed are valid for up to one year from the device external calibration.

$$\text{AbsoluteAccuracy} = \text{OutputValue} \cdot (\text{GainError}) + \text{Range} \cdot (\text{OffsetError})$$

$$\text{GainError} = \text{ResidualGainError} + \text{GainTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{ReferenceTempco} \cdot (\text{TempChangeFromLastExternalCal})$$

$$\text{OffsetError} = \text{ResidualOffsetError} + \text{AOffsetTempco} \cdot (\text{TempChangeFromLastInternalCal}) + \text{INL_Error}$$

Digital I/O/PFI

Static Characteristics

Number of channels.....	10 total
Input	6 (PFI <0..5>/P0.<0..5>)
Output	4 (PFI <6..9>/P1.<0..3>)
Ground reference.....	D GND
Direction control.....	Fixed, lines are unidirectional
Input voltage protection ¹	±20 V on up to two pins

PFI/Port 0/Port 1 Functionality

PFI <0..5>/P0.<0..5>.....	Static digital input, timing input
PFI <6..9>/P1.<0..3>.....	Static digital output, timing output
Timing output sources	Many AI, AO, counter, timing signals
Debounce filter settings.....	125 ns, 6.425 μs, 2.54 ms, disable; high and low transitions; selectable per input

Digital Input Characteristics

Level	Min	Max
V _{IL} input low voltage	0 V	0.8 V
V _{IH} input high voltage	2 V	5.25 V
I _{IL} input low current (V _{in} = 0 V)	—	−10 μA
I _{IH} input high current (V _{in} = 5 V)	—	10 μA

Digital Output Characteristics

Guaranteed output levels

Parameter	Voltage Level	Current Level
V _{OL}	0.4 V	7 mA
	0.6 V	10 mA
V _{OH}	2.8 V	−24 mA
	4.0 V	−6 mA

Maximum operation conditions

Level	Min	Max
I _{OL} output low current P1.<0..3>	—	10 mA
I _{OH} output high current P1.<0..3>	—	−24 mA

General-Purpose Counter/Timers

Number of counter/timers	2
Resolution	32 bits
Counter measurements.....	Edge counting, pulse, semi-period, period, two-edge separation
Position measurements	X1, X2, X4 quadrature encoding with Channel Z reloading; two-pulse encoding
Output applications	Pulse, pulse train with dynamic updates, frequency division, equivalent time sampling
Internal base clocks.....	80 MHz, 20 MHz, 0.1 MHz
External base clock frequency	0 MHz to 20 MHz
Base clock accuracy.....	50 ppm
Inputs	Gate, Source, HW_Arm, Aux, A, B, Z, Up_Down
Routing options for inputs	Any input PFI, RTSI, PXI_TRIG, PXI_STAR, many internal signals
FIFO.....	2 samples
Data transfers	Dedicated scatter-gather DMA controller for each counter/timer; interrupts; programmed I/O

¹ Stresses beyond those listed under *Input voltage protection* may cause permanent damage to the device.

Isolation Effects

Maximum propagation delay through isolator

Digital inputs 35 ns

Digital outputs 45 ns

Propagation delay skew between channels

(inputs and outputs) 15 ns

Frequency Generator

Number of channels 1

Base clocks 10 MHz, 100 kHz

Divisors 1 to 16

Base clock accuracy 50 ppm

Output can be available on any output PFI or RTSI terminal.

Phase-Locked Loop (PLL)

Number of PLLs 1

Reference signal PXI_STAR,
PXI_CLK10,
RTSI <0..7>

Output of PLL 80 MHz Timebase;
other signals derived
from 80 MHz Timebase
including 20 MHz and
100 kHz Timebases

External Digital Triggers

Source Any input PFI, RTSI,
PXI_TRIG,
PXI_STAR

Polarity Software-selectable
for most signals

Analog input function Start Trigger,
Reference Trigger,
Pause Trigger,
Sample Clock,
Convert Clock,
Sample Clock Timebase

Analog output function Start Trigger,
Pause Trigger,
Sample Clock,
Sample Clock Timebase

Counter/timer functions Gate, Source, HW_Arm,
Aux, A, B, Z, Up_Down

Device-To-Device Trigger Bus

PCI devices RTSI <0..7>¹

PXI devices PXI_TRIG <0..7>,
PXI_STAR

Output selections 10 MHz Reference Clock;
frequency generator
output;
many internal signals

Debounce filter settings 125 ns, 6.425 μ s,
2.54 ms, disabled;
high and low transitions;
selectable per input

Bus Interface

PCI or PXI 3.3 V or 5 V signal
environment

PXI-6230 devices can be installed in PXI slots or PXI Express
hybrid slots.

DMA channels 4, analog input,
analog output,
counter/timer 0,
counter/timer 1

Power Requirements

Current draw from bus during no-load condition

+5 V 0.5 A

+12 V 20 mA

Current draw from bus during AI and AO overvoltage
condition

+5 V 0.75 A

+12 V 20 mA

Physical Requirements

Printed circuit board dimensions

NI PCI-6230 9.7 cm \times 15.5 cm
(3.8 in. \times 6.1 in.)

NI PXI-6230 Standard 3U PXI

Weight

NI PCI-6230 110 g (3.8 oz)

NI PXI-6230 150 g (5.2 oz)

I/O connector 37-pin D-SUB

¹ In other sections of this document, *RTSI* refers to RTSI <0..7> for PCI devices or PXI_TRIG <0..7> for PXI devices.

Maximum Working Voltage¹

Channel-to-earth ground²

Continuous	≤30 Vrms/60 VDC
	Measurement Category I ³
Withstand	≤840 Vrms/1200 VDC,
	verified by a 5 s dielectric
	withstand test

Channel-to-bus⁴

Continuous	≤30 Vrms/60 VDC
	Measurement Category I ³
Withstand	≤1400 Vrms/1950 VDC,
	verified by a 5 s dielectric
	withstand test

Analog channel to AI GND/AO GND

(in Figure 1, $ V_a - V_c $).....	≤11 V,
	Measurement Category I ³

Digital channel to D GND

(in Figure 1, $V_b - V_c$)	≤5.25 V,
	Measurement Category I ³



Caution This device is rated for Measurement Category I and the voltage across the isolation barrier is limited to no greater than 30 Vrms/60 VDC/42.4 V_{pk} continuous. Do not use for measurements within Categories II, III, or IV.

Figure 1 illustrates the maximum working voltage specifications.

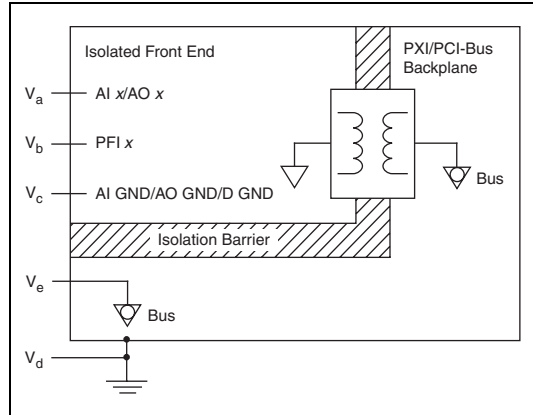


Figure 1. NI 6230 Maximum Working Voltage

Environmental

Maximum altitude..... 2,000 m (at 25 °C ambient temperature)

Pollution Degree 2

Indoor use only.

Operating Environment

Ambient temperature range 0 to 55 °C (Tested in accordance with IEC-60068-2-1 and IEC-60068-2-2.)

Relative humidity range..... 10% to 90%, noncondensing (Tested in accordance with IEC-60068-2-56.)

Storage Environment

Ambient temperature range -40 to 70 °C (Tested in accordance with IEC-60068-2-1 and IEC-60068-2-2.)

¹ Maximum working voltage refers to the signal voltage plus the common-mode voltage.

² In Figure 1, $|V_a - V_d|$, $|V_b - V_d|$, and $|V_c - V_d|$.

³ Measurement Category I is for measurements performed on circuits not directly connected to the electrical distribution system referred to as MAINS voltage. MAINS is a hazardous live electrical supply system that powers equipment. This category is for measurements of voltages from specially protected secondary circuits. Such voltage measurements include signal levels, special equipment, limited-energy parts of equipment, circuits powered by regulated low-voltage sources, and electronics.

⁴ In Figure 1, $|V_a - V_c|$, $|V_b - V_c|$, and $|V_c - V_c|$.

Relative humidity range..... 5% to 95%
 noncondensing (Tested
 in accordance with
 IEC-60068-2-56.)

Shock and Vibration (PXI Only)

Operational shock 30 g peak, half-sine,
 11 ms pulse
 (Tested in accordance
 with IEC-60068-2-27.
 Test profile developed
 in accordance with
 MIL-PRF-28800F.)

Random vibration

Operating 5 to 500 Hz, 0.3 g_{rms}
 Nonoperating 5 to 500 Hz, 2.4 g_{rms}
 (Tested in accordance
 with IEC-60068-2-64.
 Nonoperating test profile
 exceeds the requirements
 of MIL-PRF-28800F,
 Class 3.)

Safety

This product is designed to meet the requirements of the following standards of safety for electrical equipment for measurement, control, and laboratory use:

- IEC 61010-1, EN-61010-1
- UL 61010-1, CAN/CSA-C22.2 No. 61010-1



Note For UL and other safety certifications, refer to the product label or visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Electromagnetic Compatibility

This product is designed to meet the requirements of the following standards of EMC for electrical equipment for measurement, control, and laboratory use:

- EN 61326 EMC requirements; Minimum Immunity
- EN 55011 Emissions; Group 1, Class A
- CE, C-Tick, ICES, and FCC Part 15 Emissions; Class A



Note For EMC compliance, operate this device according to product documentation.

CE Compliance

This product meets the essential requirements of applicable European Directives, as amended for CE marking, as follows:

- 73/23/EEC; Low-Voltage Directive (safety)
- 89/336/EEC; Electromagnetic Compatibility Directive (EMC)



Note Refer to the Declaration of Conformity (DoC) for this product for any additional regulatory compliance information. To obtain the DoC for this product, visit ni.com/certification, search by model number or product line, and click the appropriate link in the Certification column.

Waste Electrical and Electronic Equipment (WEEE)



EU Customers At the end of their life cycle, all products must be sent to a WEEE recycling center. For more information about WEEE recycling centers and National Instruments WEEE initiatives, visit ni.com/environment/weee.htm.

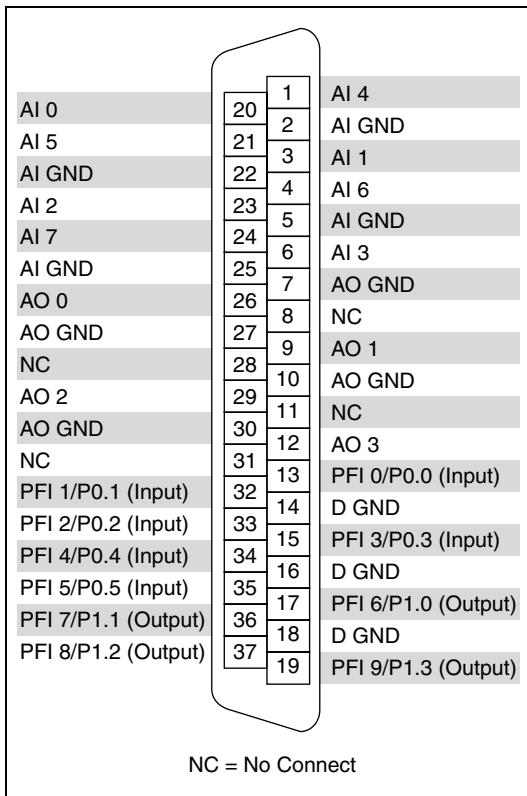


Figure 2. NI 6230 Pinout

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